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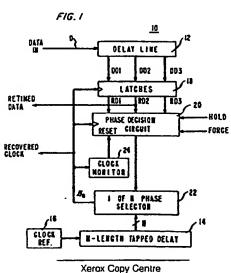
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#### Clock recovery arrangement.

(5) A digital clock recovery arrangement includes a (16,14) reference clock which provides a plurality of N signals with different clock phases. The incoming data stream is sampled and clocked with the reference clock to generate a plurality of M samples for each data bit (RD1, RD2, RD3). The logic values of the M samples are then analyzed (in 20) to determine the relationship between the current clock phase and the data bit transition. In particular, if all samples agree, the clock phase is correctly aligned with the data. If the clock phase is either leading or lagging the data, various samples will disagree. In the latter situation, the clock phase is adjusted until all samples agree, the particular clock which provides this state thus being defined as the recovered clock signal.





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#### CLOCK RECOVERY ARRANGEMENT.

This invention relates to clock recovery arrangements.

For various types of digital communication systems, it is necessary for the receiver of the information to become synchronized with the transmitted data in order to insure the validity of the received data. In most cases, the receiver includes circuits, known as clock recovery circuits, to perform this task. Many different clock recovery schemes have been developed in the past for long haul and data link applications. Most of these clock recovery schemes utilize an analog PLL arrangement, which typically comprises a phase detector (to compare the phase of the received digital data signal with that of a clock signal), a low pass filter to convert an error signal from the phase detector to an error voltage, and a voltage-controlled oscillator (VCO) having an output frequency that is controlled by the generated error voltage. Most analog PLL circuits, however, are relatively complex and contain various capacitors and resistor components which cannot be easily integrated to form a monolithic structure.

Digital phase-locked loop recovery schemes have also been utilized in the past. One such arrangement is disclosed in U.S. Patent 3,983,498 issued to C. J. Malek on September 28, 1976. Malek utilizes an oscillator, programmable frequency divider, phase detector, and data transition detector. The transition detector is used to generate a pulse of defined width at each data transition. The oscillator is used to generate a fixed frequency signal which is subsequently divided down to the desired clock frequency by the programmable frequency divider. To synchronize the phase of the clock signal with the data transitions, the phase of the data is compared with the phase of the oscillator in the phase detector. Depending upon whether the clock phase leads or lags the data phase, the divisor of the programmable divider is adjusted so as to advance or retard the clock phase to achieve synchronization. A problem with the Malek DPLL scheme, however, is that the adjustments to the clock phase are made at every data transition, tending to cause excessive phase jitter in the clock output cycle.

Therefore, a need remains in the prior art for a clock recovery scheme which can provide fast acquisition of the clock, regardless of the type of encoding of the incoming data stream.

#### Summary of the Invention

The need remaining in the prior art is addressed by the present invention which utilizes a fixed local clock (crystal oscillator) to generate a plurality of phase delayed clock pulses. The incoming data is sampled at different locations during the local clock interval, where these samples are then analyzed to determine if the clock phase is accurate, or needs to be adjusted. If all the samples agree in value, no phase adjustment is required. Otherwise, the phase will be incremented or decremented until all samples agree. A sample in the middle of the interval is defined as the retimed data output signal, since the midpoint sample value will most likely represent valid data, regardless of the degree of misalignment between the data and the clock.

In one embodiment of the present invention, a programmable logic array (PLA) may be utilized to perform the phase adjustment, using as input information the current clock phase value and the data sample values. The PLA, by virtue of its design, is also able to "remember" its previous phase adjustment command, where this attribute may be utilized to prevent the arrangement from oscillating between two clock phases as a result of sending alternating commands of increment and decrement. Additional features may be incorporated with this scheme, including the ability to "lock" or hold the phase at any predetermined value, as well as the ability to force the phase through a particular adjustment sequence.

The invention will now be described by way of example with reference to the accompanying drawings, in which:

- FIG. 1 illustrates, in block diagram form, an exemplary arrangement embodying the invention;
- Fig. 2 is a timing diagram illustrating an incoming data stream which is aligned in phase with the local clock:
- FIG. 3 illustrates, in the form of a set of timing diagrams, the steps involved in decrementing the phase of the local clock to synchronize with the incoming data;
- FIG.4 illustrates, in the form of a set of timing diagrams, an incoming data stream which is sampled at a higher rate to accelerate the phase adjustment process; and

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FIG.5 illustrates, in block diagram form, an alternative arrangement for performing clock recovery which requires one less tapped delay line when compared with the arrangement illustrated in FIG. 1.

FIG. 1 illustrates an exemplary DPLL clock recovery arrangement 10 embodying the invention. As shown, clock recovery arrangement 10 comprises first and second tapped delay lines 12 and 14, respectively, a reference clock 16, a set of latches 18, a phase decision circuit 20 and a phase selector 22.

The received data stream D is applied as an input to first delay line 12, where delay line 12 functions to generate as an output three separate waveforms, denoted DD1, DD2 and DD3, each a distinct, delayed representation of the input D. A plurality of N reference clocks, each of the same frequency but separated in phase by the value  $\Delta \phi$  are produced by second tapped delay line 14. As seen by reference to FIG. 1, reference clock 16, which may be a crystal oscillator, is applied as the input to N-length second delay line 14 to generate the N clock signals. The number of taps, N, determines the obtainable resolution between adjacent phase values. For example, with N = 10 and a 20 MHz reference clock, each clock output will be shifted in phase by 5ns. The plurality of N clock signals are applied as separate inputs to clock selector 22 which functions to produce as an output the clock signal with the desired phase.

This output, as shown in FIG. 1, is utilized as the clock input to latches 18, where the remaining inputs to latches 18 are the three waveforms DD1, DD2, and DD3. The outputs from latches 18, clocked logic values of these waveforms, are thus defined as retimed data samples RD1, RD2, and RD3.

With the availability of the N different clock phases, the problem of clock recovery thus reduces to merely selecting the proper phase of the presented N phases. This selection is accomplished by a phase decision circuit 20, which receives as inputs the retimed data samples RD1, RD2, and RD3, as well as the current phase of the clock  $\phi_n$ . In accordance with the teachings of the present invention, phase decision circuit 20 compares the values of RD1, RD2, and RD3 to determine whether the current clock phase is correct or requires modification (incrementing or decrementing). FIGS. 2 and 3 are helpful in explaining the operation of circuit 20.

Referring to FIG. 2, a timing diagram is shown of incoming data. The clock signal is represented by the vertical lines. The locations of RD1, RD2, and RD3 for each data bit are indicated by their respective numerals in FIG. 2. For this particular example, RD1 may represent the 10% interval of the data bit, RD2 the 50% interval, and RD3 the 90% interval. Other interval values for RD1 and RD3 may be used, for example, 25% and 75%, respectively. In accordance with the teachings of the present invention, however, the middle sample value must be chosen at or near the 50% interval since this position of the data bit will most likely represent the correct data bit value, regardless of the initial misalignment of the clock. Therefore, RD2 is utilized as the retimed data output of recovery arrangement 10. For the particular situation illustrated in FIG. 2, data samples RD1, RD2 and RD3 will always be identical in value, since the phase of the clock is correctly synchronized with the data stream. That is, the RD1-RD2-RD3 inputs to decision circuit 18 will either be "1-1-1" or "0-0-0." Provided with this input, decision circuit 20 will transmit a "no change" output signal to phase selector 22.

In most cases, the initially received data stream will not be in phase with the clock and some adjustment will be required. FIG. 3 illustrates a typical example when the clock phase is leading the data stream. In FIG. 3(a), both samples RD1 and RD2 comprise the same logic "0" value. However, a data bit transition has occurred before the third sample is taken, so sample RD3 will have a logic "1" value. The input "0-0-1" thus presented to decision circuit 20 will result in the generation of a "decrement" output which is subsequently applied as an input to selector 22. Selector 22 then performs a  $-\Delta \phi$  adjustment, providing a clock with this modified phase to latches 18 and circuit 20. The result of this adjustment for the next data bit is shown in FIG. 3(b), where the phase has been adjusted by  $\Delta \phi$ . Although the misalignment is less, the data is still not synchronous with the clock, the new inputs to decision circuit 18 being"1-1-0." This input to circuit 20 directs the generation of another "decrement" output to selector 22, resulting in another  $-\Delta \phi$  shift in the clock phase. The result of this second adjustment is shown in FIG. 3(c). This last adjustment, as can be seen, has caused the clock to be correctly aligned with the data, where RD1, RD2, and RD3 are now all the same logic "0" value. Presented with this "0-0-0" input, circuit 20 will now instruct selector 22 to maintain, or hold, the present clock phase, as long as the sampled data points continue to agree in value.

The alternative situation, that is, where the clock phase lags the data transitions, is also possible. For example, sample RD1 may comprise a logic "1" value, while both RD2 and RD3 are at a logic "0" value. This input of "1-0-0" to decision circuit 20 causes the circuit to generate an "increment" output, which is subsequently applied as an input to selector 22. Selector 22, in response, advances the current clock phase by the amount  $\Delta \phi$ , and transmits a clock signal with this new phase back to latches 18 and circuit 20.

It is to be understood that for either the "decrement" or "increment" situation, it may take more than

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one clock cycle to provide the full phase adjustment. This will occur when the first clock phase selected to be used is severely misaligned with the incoming data. Alternatively, if extremely small phase adjustments  $\Delta \phi$  are implemented, the number of phase corrections required will increase accordingly.

The following table summarizes the actions of decision circuit 20 in response to the sampled data inputs.

Inputs			Output	
RD1	RD2	RD3	φ1	
1	1	1	hold	
0	0	0	hold	
1	1	0	decrement	
0	0	1	decrement	
1	0	0	increment	
0	1	1	increment	

As discussed above, the size of the phase adjustment  $\Delta \phi$  is a function of the number of taps, N, forming tapped delay line 14. In particular, as the number of taps increases, the size of the phase adjustment will decrease. By decreasing  $\Delta \phi$ , it is possible to provide a more accurate alignment of the clock phase to the data. However, this requires the use of a larger tapped delay line and may also result in requiring a longer period of time to complete the alignment process.

In an exemplary embodiment of the present invention, the required operations of phase decision circuit 20 may be performed by a programmable logic array (PLA). A PLA, as is well known in the art, is a series of logic gates which may be coupled together in any desired arrangement to perform a series of logical functions. There exist many alternative ways in which a PLA may be configured to perform the phase adjustment function of the present invention, any of which would be fairly routine to implement for one skilled in the art and thus will not be described in detail.

When utilizing a PLA to determine the requisite phase adjustments, it is possible to use the remaining PLA capacity to incorporate additional protection and functionality into the design. In particular, it may be desirable to provide some means of assuring that the PLA selects one and only one valid phase for the clock signal. Otherwise, the PLA would continue to remain in an illegal state. To guarantee that at least one phase is selected, the PLA may be receptive to an external "RESET" signal which functions to select a particular phase by default. This default selection may be either random or fixed, according to the particular programming of the PLA. The RESET input is generated by a clock monitor 24 which functions to observe the output clock from phase selector 22. As long as phase selector 22 is generating a valid clock signal, clock monitor 24 remains inactive. However, when the recovered clock input to monitor 24 is no longer representative of the valid clock (e.g., disappearance of signal), monitor 24 transmits a RESET signal to the PLA. In one embodiment, monitor 24 may be an analog (or digital) timer which is responsive to the clock signal and functions to generate an output after a predetermined time interval has passed without the reception of a valid clock.

If more than one clock phase has been selected (due to an illegal input, for example, "1-0-1"), the PLA may also contain logic to ignore all but one selected phase. For example, the PLA may utilize a set of rules which dictate that the earliest phase be selected. Other equally valid criteria (including a randomized selection) may also be used.

Another optional external control to the PLA is indicated as "FORCE" in FIG. 1. The FORCE input, as its name implies, causes the phase adjustment to ignore the RD1, RD2 and RD3 inputs and instead step through a series of externally applied phase adjustments. This feature may be useful for applications that require the "received" clock to be aligned with the transmitter clock when there is no data being transmitted. Another optional input, labeled "HOLD" in FIG. 1, also allows the PLA to ignore the sampled data inputs. In this case, the PLA will instruct phase selector 22 to maintain its current clock selection. The HOLD function may be used in applications where there are known interruptions in the data stream and any decision of the PLA based upon the data samples would be unreliable.

Although the above description has concentrated on the utilization of three sampled data values, it is obvious that any number of sample values (greater than three) may also be used. By increasing the number of samples, additional information regarding the signal may be obtained. In particular, increasing the number of samples (to seven, for example) would aid locating the exact point of the data transition and thus decreasing the length of time needed to align the clock phase with the data. This can be explained by

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referring to FIG.4, which illustrates two different situations using seven data samples. FIG.4(a) represents the situation where the clock phase is nearly synchronous with the data, the transition in data value occurring between samples 6 and 7. Since the clock phase is nearly aligned with the data, only a few cycles through the PLA would be needed to perform this alignment, regardless of the phase adjustment interval  $\Delta\phi$ . In contrast, FIG.4(b) illustrates a situation where the phase of the clock is further misaligned with the data, the transition occurring between samples 3 and 4. The information regarding the location of the transition (i.e., sample 3 being logic "0" and sample 4 being logic "1") can be used by the PLA to tell selector 22 to increment/decrement the phase by M phase adjustments, M being greater than one. For example, the PLA may tell selector 22 to increase the clock phase by three adjustment intervals. By performing this larger phase adjustment, the overall time taken to correctly align the clock with the data will decrease significantly. Obviously, the larger the number of samples, the easier it will be for the PLA to pinpoint the data transition.

It is to be noted that the data samples are not required to be uniformly spaced. For example, one embodiment of the present invention may utilize a series of five samples representing the 9, 19, 50, 80 and 85% intervals. Another embodiment may utilize a series of four samples (5, 10, 15, 20% intervals) before the midpoint (50%) and only two samples (75 and 90%) after the midpoint. This latter series of sample intervals may be especially important for situations where transmitting device-dependent noise characteristics (jitter, for example) are more likely to occur at the beginning of the data bit. Asymmetric sampling of the data in these situations will thus aid the phase decision circuit in establishing a valid clock phase.

Besides retiming the data and providing a recovered clock, other uses for these data samples exist. For example, the existence of pulse width distortion would become readily apparent by correlating the number of phase corrections associated with rising data transitions versus the phase corrections of falling edges. If the intervals associated with falling edges produce phase corrections of the opposite sign than intervals associated with rising edges, then pulse width distortion is most likely present. Additionally, the degree of jitter in the data stream may also be ascertained from the data samples.

Jitter, defined as the offset of data transition locations from their ideally clocked positions, may result in the input of erroneous data bit samples to the phase decision circuit. These samples may then cause the phase decision circuit to request an unnecessary change in the clock phase. Therefore, by monitoring the number of these requests which occur after clock alignment has been achieved, information regarding the presence of jitter may be acquired. Further, if more than three data bit samples are used, it is also possible to determine certain characteristics (Gaussian nature, for example) of the jitter.

An alternative embodiment 30 of the clock recovery scheme of the present invention is illustrated in FIG. 5. This embodiment utilizes a different clocking arrangement which results in eliminating the tapped delay line utilized to generate the data samples. Referring to FIG. 5, retimed data samples RD1, RD2, and RD3 are formed by latches 32, 34 and 36, respectively, where each latch is responsive to a clock with a different phase. These phases, denoted  $\phi_{n-y}$   $\phi_n$ , and  $\phi_{n+x}$  are generated by a phase selector 38. Similar to phase selector 22, phase selector 38 generates a clock signal with the current selected phase,  $\phi_n$ . Additionally, phase selector 38 generates a clock signal with a phase lagging the current phase by a predetermined amount  $\phi_{n-y}$ , as well as a signal with a phase leading the current phase by this predetermined amount,  $\phi_{n+x}$ . Lagging clock signal  $\phi_{n-y}$ , as shown in FIG. 5 is applied as the clock input to latch 32, thus producing as an output retimed data sample RD1. Clock signal  $\phi_n$  is applied as an input to latch 34 to produce retimed data sample RD2, where this data sample is used as the DATA OUT of recovery circuit 30. Lastly, leading clock signal  $\phi_{n+x}$  is applied as the clock input to latch 36 to generate as the output retimed data sample RD3. Another clock signal  $\phi_{n+x}$  is applied as the clock input to phase decision circuit 20, where clock signal  $\phi_{n+x}$  may be one of three signals transmitted to latches 32, 34, 36, or, alternatively, another selected clock phase.

The sampled data values of RD1, RD2 and RD3 are applied as inputs to phase decision circuit 20, which functions in the manner described above to determine the current phase relationship between the incoming data stream and the locally generated clock. As discussed above, clock monitor 24 may be added to insure that phase decision circuit 20 always provides a valid clock signal. Additionally, decision circuit 20 may also take the form of a PLA in this embodiment, utilizing the same external inputs to the PLA, notably, RESET, HOLD and FORCE, to provide additional features to clock recovery arrangement 30. Obviously, the embodiment of FIG. 5 may be further modified to allow for a greater number of samples to be generated for each data bit. This would require an increase in the number of output lines from selector 38, and a comparable increase in the number of associated latches.

It is to be understood that various other arrangements may exist which are capable of performing the retiming and clock recovery functions of the present invention. In particular, the clock recovery scheme may be used with any coding scheme including, but not limited to, NRZ, Manchester, etc.

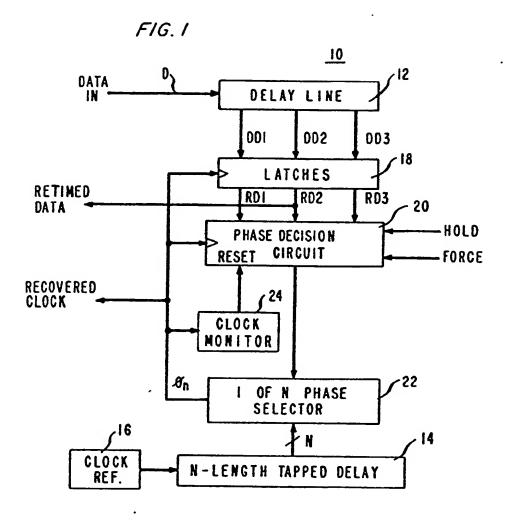
#### Claims

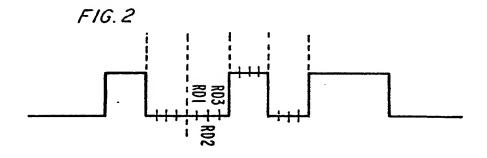
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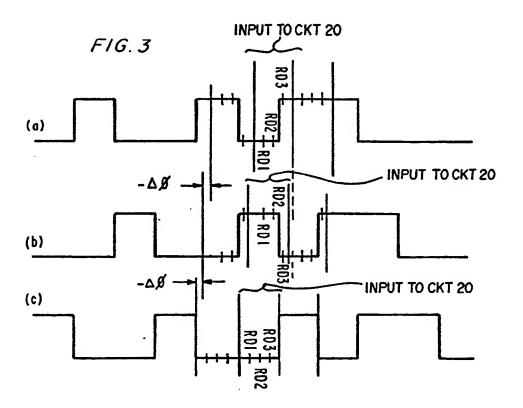
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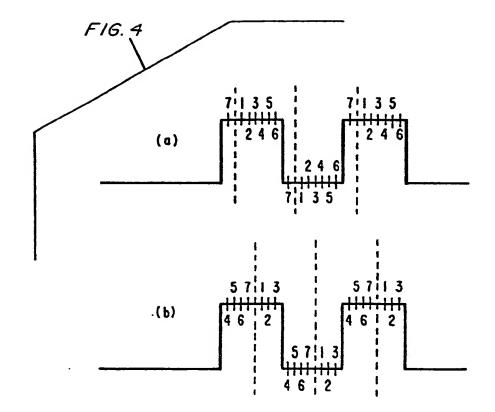
- 1. A clock recovery arrangement for generating from an incoming digital data stream a retimed data output signal and a recovered clock signal, said arrangement comprising a data input line (D) for reception of the incoming data stream, and characterised by data sampling means (12,18) coupled to the data input line for producing in dependence upon the recovered clock signal a plurality of M clocked samples (RD1,RD2,RD3) of each data bit from said incoming data stream, M being at least equal to three, one clocked sample being located at the approximate midpoint of the data bit and defined as the retimed data output of said clock recovery arrangement, at least one clocked sample being located before the midpoint, and at least one other clocked sample being located after the midpoint, means (16,14,22) for generating the recovered clock signal having a predetermined frequency and adjustable phase, and clock phase decision means (20) for comparing the logic values of said plurality of M clocked samples and adjusting the phase of the recovered clock signal if all do not agree in value.
- 2. An arrangement as claimed in claim 1 comprising clock monitoring means (24) responsive to the recovered clock signal for generating as an output a reset signal when said recovered clock signal is not present, the clock phase decision means being responsive to the reset signal to provide a predetermined phase of clock signal, regardless of the values of the clocked samples.
- 3. An arrangement as claimed in claim 2 wherein the clock monitoring means comprises an analog timing circuit.
- 4. An arrangement as claimed in claim 2 wherein the clock monitoring means comprises a digital timing circuit.
- 5. An arrangement as claimed in claim 1, 2, 3 or 4 wherein the clock phase decision means comprises programmable logic array means responsive to the plurality of M clocked samples for generating as an output a phase decision signal for adjusting the phase of the recovered clock signal.
- 6. An arrangement as claimed in claim 5 wherein the programmable logic array means is responsive to an external hold control signal to maintain the recovered clock signal at a predetermined clock phase regardless of the values of the plurality of M clocked samples.
- 7. An arrangement as claimed in claim 5 or 6 wherein the programmable logic array means is responsive to an external force control signal to adjust the recovered clock signal through a predetermined series of clock phases regardless of the values of the plurality of M clocked samples.
- 8. An arrangement as claimed in any preceding claim wherein the data sampling means comprises an M-length tapped delay line (12) responsive to the incoming digital data stream for producing as parallel outputs a plurality of M sampled data bits, and a plurality of M latches (18), each latch being responsive to a respective one of the plurality of M sampled data bits and the recovered clock signal for producing as an output the plurality of M clocked samples.
- 9. An arrangement as claimed in any one of claims 1 to 7 comprising means (38) for generating a plurality of M clock signals, one clock signal comprising the recovered clock signal, X clock signals comprising clock phases leading the recovered clock signal (X<M), and M-1-X clock signals comprising clock phases leading the recovered clock signal, and wherein the data sampling means comprises a plurality of M clocked latches (32,34,36) responsive to the incoming digital data stream, each latch being responsive to a respective one of the plurality of M clock signals, said plurality of M latches serving to produce as an output the plurality of M clocked samples.
- 10. An arrangement as claimed in any preceding claim wherein the means for generating the recovered clock signal comprises clock means (16) for generating a reference clock signal at the predetermined frequency, means (14) for deriving from the reference clock signal a plurality of N clock signals at the predetermined frequency, adjacent clock signals being separated in phase by 360°N, and means (22) controlled by the clock phase decision means for selecting one of the N clock signals as the recovered output signal.
  - 11. An arrangement as claimed in any preceding claim wherein M = 3.
- 12. An arrangement as claimed in claim 10 wherein M>3, and the clock phase decision means serves to control the selecting means to adjust the phase of the recovered clock signal by more than one clock phase separation at a time as a function of the location of the change in logic value between adjacent data bit samples.

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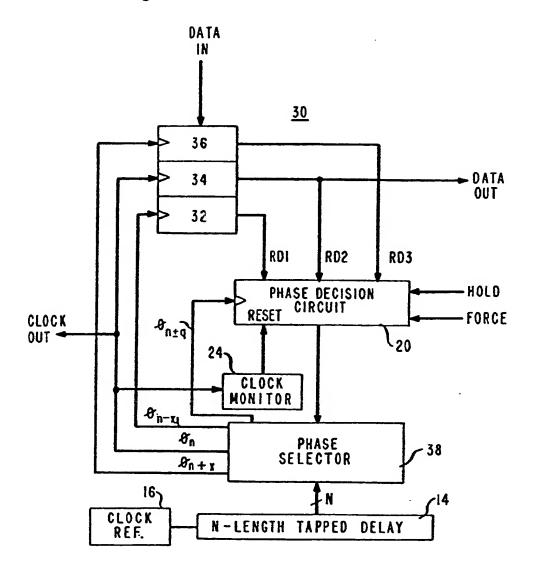






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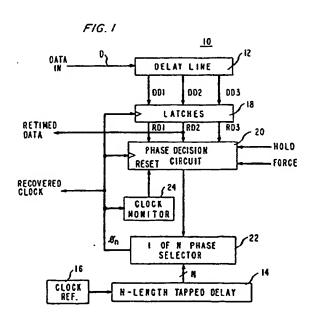
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#### (S) Clock recovery arrangement.

(57) A digital clock recovery arrangement includes a (16,14) reference clock which provides a plurality of N signals with different clock phases. The incoming data stream is sampled and clocked with the reference clock to generate a plurality of M samples for each data bit (RD1, RD2, RD3). The logic values of the M samples are then analyzed (in 20) to determine the relationship between the current clock phase and the data bit transition. In particular, if all samples agree, the clock phase is correctly aligned with the data. If the clock phase is either leading or lagging the data, various samples will disagree. In the latter situation, the clock phase is adjusted until nall samples agree, the particular clock which provides this state thus being defined as the recovered clock signal.



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## **EUROPEAN SEARCH REPORT**

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Category	Citation of document with in- of relevant pas	dication, where appropriate,	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. Cl. 4)	
X	US-A-4 415 984 (GRY * Column 4, lines 7-64 - column 6, line 63 - column 8, line	GER et al.) -45; column 4, line 1; column 6, line	1,2,5,8	H 04 L 7/02	
A	US-A-4 012 598 (WILL  * Column 1, line 55 47; column 3, line 1 12; column 4, line 4 24 *	- column 2, line L8 - column 4, line	1,8-12		
A	TELECOM & RADIO ENG: 31/32, no. 8, August A.S. GEORGIYEV: "A system with digital high-speed data trait The whole document	t 1977, pages 22-24; synchronization control in nsmission"	1,8-10,		
				TECHNICAL FIELDS SEARCHED (Int. Cl.4)	
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